

ISOTOP[®] Boost chopper NPT IGBT

$V_{CES} = 600V$ $I_C = 30A$ @ Tc = 100°C

Application • AC • Swi

- AC and DC motor control
 Switched Mode Power Supplies
 Power Factor Correction
- Power Factor C
- Brake switch

Features

- Non Punch Through (NPT) THUNDERBOLT IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 100 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- ISOTOP[®] Package (SOT-227)
- Very low stray inductance
- High level of integration

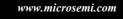
Benefits

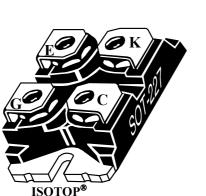
- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_C of V_{CEsat}
- RoHS Compliant
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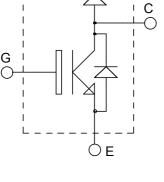
Absolute maximum ratings

Symbol	Parameter			Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage			600	V
I _{C1}	Continuous Collector Current	58			
I _{C2}	Continuous Collector Current		$T_{\rm C} = 100^{\circ}{\rm C}$	30	Α
I _{CM}	Pulsed Collector Current $T_{\rm C} = 25^{\circ}{\rm C}$			110	
V _{GE}	Gate – Emitter Voltage			±20	V
P _D	Maximum Power Dissipation		$T_C = 25^{\circ}C$	192	W
I_{LM}	RBSOA clamped Inductive load Current $R_G=11\Omega$		$T_C = 25^{\circ}C$	60	А
IF _{AV}	Maximum Average Forward Current	Duty cycle=0.5	$T_C = 80^{\circ}C$	30	А
IF _{RMS}	RMS Forward Current (Square wave, 50% duty)			39	Λ

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.







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All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I _{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$V_{\rm GE} = 0 V$ $T_{\rm j} = 25^{\circ} C$			40	μA
		$V_{CE} = 600 V$ $T_j = 12$	$T_j = 125^{\circ}C$			1000	μΑ
V _{CE(sat)}	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		2.0	2.5	V
	Conector Ennitier saturation voltage	$I_C = 30A$	$T_j = 125^{\circ}C$		2.2	2.8	v
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 700 \mu A$		3	4	5	V
I _{GES}	Gate – Emitter Leakage Current	$V_{GE} = \pm 20 V, V_{CE} = 0 V$				±100	nA

Dynamic Characteristics

	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		1600	1850	
C _{oes}	Output Capacitance	$V_{CE} = 25V$		150	220	pF
C _{res}	Reverse Transfer Capacitance	f=1MHz		90	150	
Qg	Total gate Charge	$V_{GS} = 15V$		140	210	
Q _{ge}	Gate – Emitter Charge	$V_{Bus} = 300V$		10	15	nC
Q _{gc}	Gate – Collector Charge	$I_C = 30A$		60	90	
T _{d(on)}	Turn-on Delay Time	Resistive Switching (25°C)		13	26	ns
T _r	Rise Time	$V_{GE} = 15V$ $V_{GE} = 200V$		41	80	
T _{d(off)}	Turn-off Delay Time	$\frac{V_{Bus} = 300V}{I_C = 30A}$		147	220	
T _f	Fall Time	$R_{G} = 10\Omega$		200	400	
T _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C)		17	30	ns
Tr	Rise Time	$V_{GE} = 15V$		28	60	
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 400V$ $I_{C} = 30A$ $R_{G} = 10\Omega$		242	360	
T _f	Fall Time			34	70	
Ets	Total switching Losses			1.2	2	mJ
T _{d(on)}	Turn-on Delay Time	Inductive Switching (150°C)		15	30	
Tr	Rise Time	$V_{GE} = 15V$		27	50	
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 400V$ $I_{C} = 30A$ $R_{G} = 10\Omega$		265	400	ns
T _f	Fall Time			41	80	
Eon	Turn-on Switching Energy			0.5	1	
E _{off}	Turn-off Switching Energy			1	2	mJ
E _{ts}	Total switching Losses			1.5	3	



Chopper diode ratings and characteristics

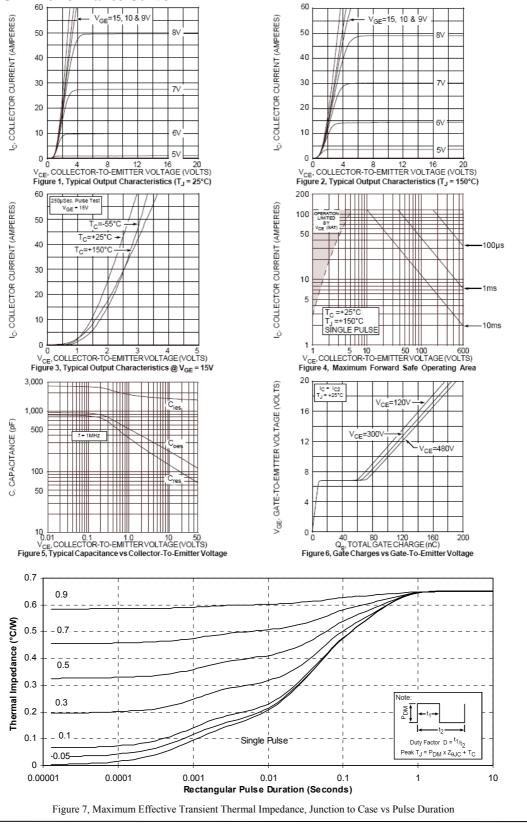
Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
	Diode Forward Voltage	$I_F = 30A$			1.6	1.8	
$V_{\rm F}$		$I_F = 60A$			1.9		V
		$I_F = 30A$	$T_{i} = 125^{\circ}C$		1.4		
I _{RM}	Maximum Reverse Leakage Current	$V_{R} = 600 V$	$T_j = 25^{\circ}C$			250	μA
IKM		$V_{R} = 600 V$	$T_{j} = 125^{\circ}C$			500	μΑ
C _T	Junction Capacitance	$V_{R} = 200V$			44		pF
	Reverse Recovery Time	$I_F=1A, V_R=30V$ di/dt =100A/µs	$T_j = 25^{\circ}C$		23		
t _{rr}	Reverse Recovery Time	$T_i = 25^{\circ}C$ $T_i = 125^{\circ}C$	$T_i = 25^{\circ}C$		85		ns
				160			
т	Maximum Reverse Recovery Current	$I_F = 30A$	$T_j = 25^{\circ}C$		4		А
I _{RRM}	Maximum Reverse Recovery Current	$V_{\rm R} = 400 V$	$T_{i} = 125^{\circ}C$		8		А
0	Pawaraa Paaawary Charga	$di/dt = 200 A/\mu s$	$T_j = 25^{\circ}C$		130		nC
Q _{rr}	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		700		nC
t _{rr}	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 1000A/\mu s$			70		ns
Q _{rr}	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		1300		nC
I _{RRM}	Maximum Reverse Recovery Current				30		Α

Thermal and package characteristics

Symbol	Characteristic		Min	Тур	Max	Unit	
R _{thJC}	Junction to Case	IGBT			0.65		
		Diode			1.21	°C/W	
R _{thJA}	Junction to Ambient (IGBT & Diode)				20		
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz		2500			V	
T_J, T_{STG}	Storage Temperature Range		-55		150	°C	
T _L	Max Lead Temp for Soldering:0.063" from case for 10 sec				300		
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m	
Wt	Package Weight			29.2		g	



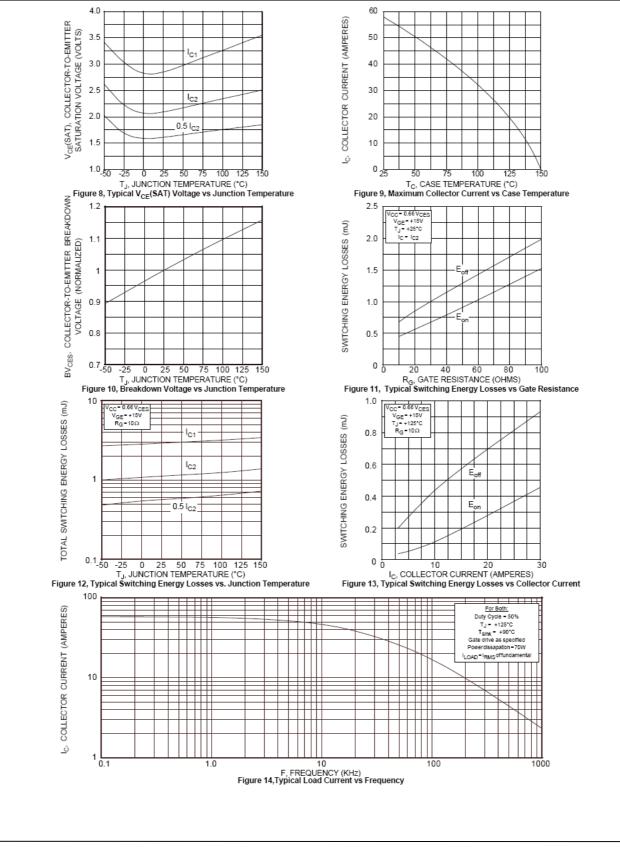
Typical IGBT Performance Curve



APT30GF60JU2

APT30GF60JU2 - Rev 2 October, 2012





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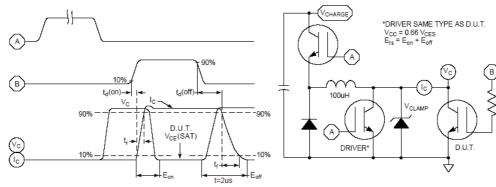


Figure 15, Switching Loss Test Circuit and Waveforms

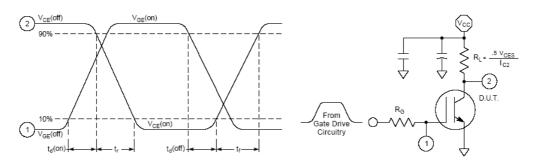
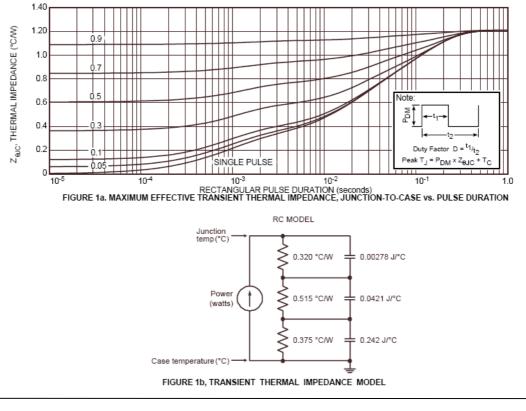
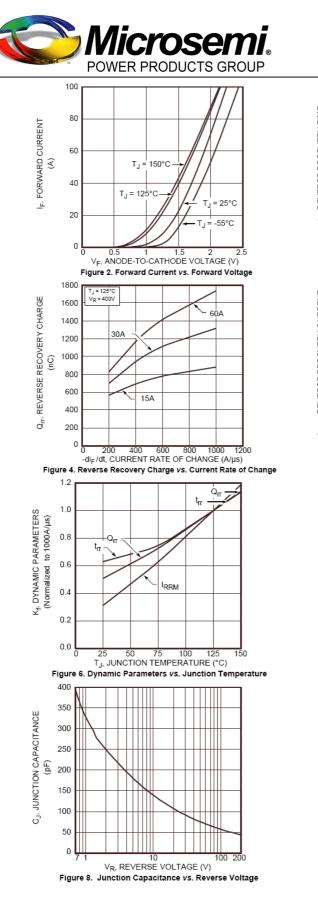
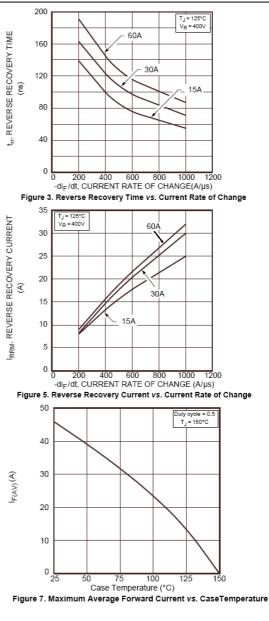


Figure 16, Resistive Switching Time Test Circuit and Waveforms

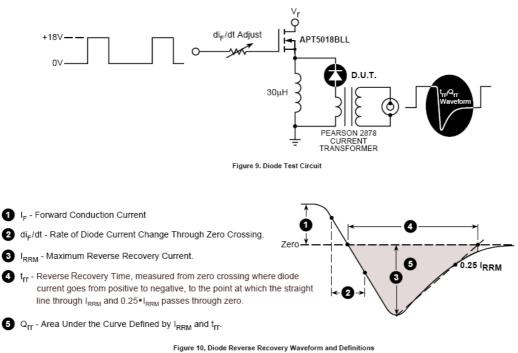


Typical Diode Performance Curve

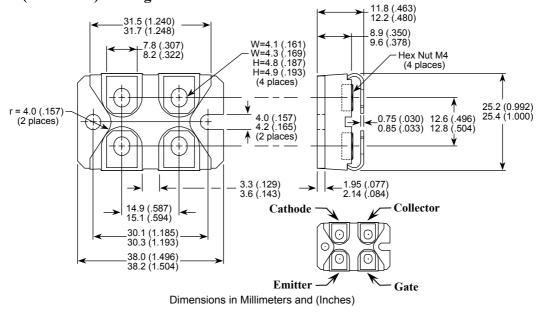








SOT-227 (ISOTOP[®]) Package Outline



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